

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10598836	SCHOBEN ET AL.
	<b>Examiner</b> KE XIAO	<b>Art Unit</b> 2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	156, 173, 179-183	8/28/2008	LW
178	18.01-19.05	8/28/2008	LW
715	702, 773	8/28/2008	LW
	Updated Above	3/23/2009	KX
	Updated Above	9/16/2009	KX
	Updated Above	2/24/2010	KX
	Updated Above	7/21/2010	KX
	Updated Above	2/15/2011	KX
	Updated Above	8/4/2011	KX

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East Search (US-PGPUB, USPAT, EPO, JPO)	8/28/2008	LW
Updated Above	3/23/2009	KX
Updated Above	9/16/2009	KX
Updated Above	2/24/2010	KX
Updated Above	7/21/2010	KX
Updated Above	2/15/2011	KX
Updated Above	8/4/2011	KX

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/KE XIAO/ Primary Examiner. Art Unit 2629
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